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Hard X-Ray, Gamma-Ray, and Neutron Detector Physics XI

**Ralph B. James
Larry A. Franks
Arnold Burger**
Editors

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Contents

ix	Conference Committee
xiii	Introduction

SESSION 1 CZT DETECTORS I

- 7449 02 **CZT device with improved sensitivity for medical imaging and homeland security applications (Invited Paper)** [7449-01]
H. Chen, S. A. Awadalla, P. Marthandam, K. Iniewski, P. H. Lu, G. Bindley, Redlen Technologies (Canada)
- 7449 04 **Dual anode contact geometries for x-ray and gamma-ray spectroscopy and 3D localization** [7449-03]
J.W. Martin, A. B. Garson III, Q. Li, K. Lee, Washington Univ. in St. Louis (United States); M. Groza, V. Buliga, A. Burger, Fisk Univ. (United States); H. Krawczynski, Washington Univ. in St. Louis (United States)
- 7449 05 **Front-end ASIC for pixilated wide bandgap detectors** [7449-04]
E. Vernon, G. De Geronimo, J. Fried, Brookhaven National Lab. (United States); C. Herman, F. Zhang, Z. He, Univ. of Michigan, Ann Arbor (United States)

SESSION 2 CZT CHARACTERIZATION I

- 7449 08 **Uniformity of charge collection efficiency in Frisch collar spectrometer with THM grown CdZnTe crystals** [7449-07]
A. Kargar, A. C. Brooks, Kansas State Univ. (United States); M. J. Harrison, Univ. of Florida (United States); H. Chen, S. Awadalla, G. Bindley, B. Redden, Redlen Technologies (Canada); D. S. McGregor, Kansas State Univ. (United States)

SESSION 3 CZT DETECTORS II

- 7449 09 **Characterization of a 15-mm-long virtual Frisch-grid CZT detector array (Invited Paper)** [7449-08]
A. E. Bolotnikov, Brookhaven National Lab. (United States); S. Babalola, Fisk Univ. (United States) and Vanderbilt Univ. (United States); G. S. Camarda, Y. Cui, Brookhaven National Lab. (United States); S. U. Egarievwe, Fisk Univ. (United States); P. M. Fochuk, Chernivtsi National Univ. (Ukraine); M. Hirt, Univ. of Michigan (United States); A. Hossain, K. Kim, Brookhaven National Lab. (United States); O. V. Kopach, Chernivtsi National Univ. (Ukraine); N. D. Sferrazza, Brookhaven National Lab. (United States); J. Sturgess, Vanderbilt Univ. (United States); K. Polack, Univ. of Michigan (United States); B. Raghothamachar, Stony Brook Univ. (United States); G. Yang, R. B. James, Brookhaven National Lab. (United States)

- 7449 0A **Simulation of electric field profile in semi insulating Au/CdZnTe/Au detector under flux (Invited Paper)** [7449-09]
J. Franc, R. Grill, Charles Univ. in Prague (Czech Republic); R. James, Brookhaven National Lab. (United States); J. Kubat, E. Belas, P. Hoschl, P. Moravec, P. Praus, Charles Univ. in Prague (Czech Republic)
- 7449 0C **Electric field distribution of cadmium zinc telluride (CZT) detectors** [7449-11]
G. Yang, A. E. Bolotnikov, G. S. Camarda, Y. Cui, A. Hossain, K. Kim, R. B. James, Brookhaven National Lab. (United States)

SESSION 4 SCINTILLATORS I

- 7449 0E **Dual gamma neutron detection with Cs₂LiLaCl₆** [7449-13]
J. Glodo, R. Hawrami, E. van Loef, W. Higgins, U. Shirwadkar, K. S. Shah, Radiation Monitoring Devices, Inc. (United States)
- 7449 0F **SrI₂ scintillator for gamma ray spectroscopy** [7449-14]
N. J. Cherepy, B. W. Sturm, O. B. Drury, T. A. Hurst, S. A. Sheets, L. E. Ahle, C. K. Saw, M. A. Pearson, S. A. Payne, Lawrence Livermore National Lab. (United States); A. Burger, Fisk Univ. (United States); L. A. Boatner, J. O. Ramey, Oak Ridge National Lab. (United States); E. V. van Loef, J. Glodo, R. Hawrami, W. M. Higgins, K. S. Shah, Radiation Monitoring Devices, Inc. (United States); W. W. Moses, Lawrence Berkeley National Lab. (United States)
- 7449 0G **Angular resolution obtained with a LaBr₃-based rotational modulator** [7449-15]
B. S. Budden, G. L. Case, M. L. Cherry, Louisiana State Univ. (United States)

SESSION 5 CDTE

- 7449 0I **Development of a novel energy-resolved photon-counting detector for gamma ray imaging applications** [7449-17]
L.-J. Meng, J. W. Tan, Univ. of Illinois at Urbana-Champaign (United States); K. Spartiotis, T. Schulman, Oy AJAT Ltd. (Finland)
- 7449 0J **High-speed photon counting processing for CdTe detector** [7449-18]
B. Shinomiya, A. Koike, H. Morii, T. Okunoyama, Y. Neo, H. Mimura, T. Aoki, Shizuoka Univ. (Japan)
- 7449 0L **Far-IR reflectance spectra analysis of CdZnTe and related materials** [7449-20]
T.-R. Yang, S.-H. Jhang, Y.-H. Shih, National Taiwan Normal Univ. (Taiwan); F.-C. Hou, Y.-C. Yang, National Taiwan Univ. (Taiwan); P. Becla, Massachusetts Institute of Technology (United Kingdom); D.-C. Tien, National Taipei Univ. of Technology (Taiwan); Z. C. Feng, National Taiwan Univ. (Taiwan)

SESSION 6 CZT CHARACTERIZATION II

- 7449 0N **Characterization of secondary phases in modified vertical Bridgman growth CZT (Invited Paper)** [7449-22]
M. C. Duff, Savannah River National Lab. (United States); K. G. Lynn, K. Jones, Washington State Univ. (United States); Z. R. Dai, J. P. Bradley, N. Teslich, Lawrence Livermore National Lab. (United States)
- 7449 0Q **Synchrotron radiation x-ray absorption fine-structure and Raman studies on CdZnTe ternary alloys** [7449-25]
Y. L. Wu, Y.-T. Chen, Z. C. Feng, National Taiwan Univ. (Taiwan); J.-F. Lee, National Synchrotron Radiation Research Ctr. (Taiwan); P. Becla, Francis Bitter National Magnet Lab., MIT (United States); W. Lu, Fisk Univ. (United States)

SESSION 7 CRYSTAL GROWTH

- 7449 0U **Unseeded growth of CdZnTe:In by THM technique** [7449-29]
U. N. Roy, S. Weiller, J. Stein, A. Gueorguiev, ICx Radiation (United States)

SESSION 8 IMAGING APPLICATIONS

- 7449 0X **The ECLAIRs telescope onboard the SVOM mission for gamma-ray burst studies** [7449-32]
H.-E. Triou, B. Cordier, D. Gotz, S. Schanne, T. Tourrette, CEA, Saclay (France); P. Mandrou, R. Pons, O. Godet, N. Remou, D. Barret, Ctr. d'Etude Spatiale des Rayonnements, CNRS, UPS (France); J. Atteia, LATT (France); M. Jouret, Ctr. National d'tudes Spatiales, CST (France)
- 7449 0Y **A quantum-limited CMOS-sensor-based high-speed imaging system for time-resolved x-ray scattering** [7449-33]
B. Rodricks, B. Fowler, C. Liu, J. Lowes, Fairchild Imaging (United States); L. J. Koerner, M. W. Tate, Cornell Univ. (United States); S. M. Gruner, Cornell Univ. (United States) and Cornell High Energy Synchrotron Source (United States)
- 7449 0Z **Characterisation of an asymmetric AGATA detector** [7449-34]
C. Unsworth, A. J. Boston, H. C. Boston, S. Colosimo, J. Cresswell, M. R. Dimmock, F. Filmer, D. Judson, S. Moon, P. J. Nolan, M. J. Norman, M. Slee, Univ. of Liverpool (United Kingdom)

SESSION 9 NEUTRON DETECTORS

- 7449 10 **Neutron detector based on TimePix pixel device with micrometer spatial resolution (Invited Paper)** [7449-35]
J. Jakubek, S. Pospisil, Czech Technical Univ. in Prague (Czech Republic); J. Uher, Czech Technical Univ. in Prague (Czech Republic) and CSIRO Minerals (Australia)
- 7449 11 **Neutron detection with single crystal organic scintillators (Invited Paper)** [7449-36]
N. P. Zaitseva, J. Newby, S. Hamel, L. Carman, M. Faust, V. Lordi, N. J. Cherepy, W. Stoeffl, S. A. Payne, Lawrence Livermore National Lab. (United States)

- 7449 12 **Praseodymium activation detector for measuring bursts of 14MeV neutrons** [7449-37]
B. T. Meehan, E. C. Hagen, National Security Technologies, LLC (United States); C. L. Ruiz, G. W. Cooper, Sandia National Labs. (United States)
- 7449 13 **Neutron energy measurements in emergency response applications** [7449-38]
S. Mukhopadhyay, P. Guss, M. Hornish, S. Wilde, T. Stampahar, M. Reed, Remote Sensing Lab. (United States)
- 7449 14 **Multi-element neutron energy spectrometer** [7449-39]
S. Mukhopadhyay, R. Maurer, R. Wolff, S. Mitchell, A. Reed, Remote Sensing Lab., National Security Technologies, LLC (United States)

SESSION 10 CHALCOGENIDE DETECTORS

- 7449 18 **Properties of layered crystals for radiation detectors: TiGaSe₂ system** [7449-43]
D. J. Knuteson, N. B. Singh, D. Kahler, B. Wagner, A. Berghmans, S. McLaughlin, K. Schwartz, Northrop Grumman Corp. (United States)

SESSION 11 CMT AND TIBR

- 7449 1A **Effect of Te inclusions on internal electric field of CdMnTe gamma-ray detector** [7449-45]
O. S. Babalola, Vanderbilt Univ. (United States), Fisk Univ. (United States), and Brookhaven National Lab. (United States); A. E. Bolotnikov, S. U. Egarevwe, A. M. Hossain, Brookhaven National Lab. (United States); A. Burger, Fisk Univ. (United States); R. B. James, Brookhaven National Lab. (United States)
- 7449 1D **Fabrication of TlBr strip detectors** [7449-48]
K. Hitomi, Y. Kikuchi, M. Nakhostin, Tohoku Univ. (Japan); T. Shoji, Tohoku Institute of Technology (Japan); K. Ishii, Tohoku Univ. (Japan)

SESSION 12 SCINTILLATORS II

- 7449 1E **Rare-earth tri-halides methanol-adduct single-crystal scintillators for gamma ray and neutron detection (Invited Paper)** [7449-49]
L. A. Boatner, D. J. Wisniewski, J. S. Neal, Z. W. Bell, J. O. Ramey, J. A. Kolopus, B. C. Chakoumakos, R. Custelcean, M. Wisniewska, K. E. Pena, Oak Ridge National Lab. (United States)
- 7449 1G **High-resolution x-ray and γ-ray imaging using a scintillator-coupled electron-multiplying CCD** [7449-52]
D. Hall, A. Holland, The Open Univ. (United Kingdom)

SESSION 13 OTHER NOVEL DETECTOR MATERIALS

- 7449 1H **Semiconducting material property relationships: trends and their impact on design of radiation detection materials** [7449-53]
K. F. Ferris, S. K. Lockersbie, B.-J. M. Webb-Robertson, Pacific Northwest National Lab. (United States); D. M. Jones, Proximate Technologies, LLC (United States)

- 7449 1I **Flexible radiation dosimeters incorporating semiconducting polymer thick films** [7449-54]
C. A. Mills, A. Intaniwet, M. Shkunov, J. L. Keddie, P. J. Sellin, Univ. of Surrey (United Kingdom)

POSTER SESSION

- 7449 1M **Bismuth tri-iodide radiation detector development** [7449-58]
A. T. Lintereur, W. Qiu, J. C. Nino, J. E. Baciak, Univ. of Florida (United States)
- 7449 1P **Comparison of neutron sensitive scintillators for use with a solid-state optical detector** [7449-61]
S. Mukhopadhyay, C. Stapels, E. B. Johnson, E. C. Chapman, P. S. Lindsay, Radiation Monitoring Devices, Inc. (United States); T. H. Prettyman, Planetary Science Institute (United States); M. R. Squillante, J. F. Christian, Radiation Monitoring Devices, Inc. (United States)
- 7449 1R **Generic materials property data storage and retrieval for the semiconducting materials knowledge base** [7449-63]
D. M. Jones, Proximate Technologies, LLC (United States); K. F. Ferris, B.-J. M. Webb-Robertson, Pacific Northwest National Lab. (United States); J. T. Muellerleile, Proximate Technologies, LLC (United States); R. W. Hyatt, Battelle Memorial Institute (United States)
- 7449 1U **HgS: a rugged, stable semiconductor radiation detector material** [7449-66]
M. R. Squillante, W. M. Higgins, H. Kim, L. Cirignano, G. Ciampi, A. Churilov, K. Shah, Radiation Monitoring Devices, Inc. (United States)
- 7449 1W **Design and modeling of a lateral α -Se MSM photoconductor as indirect conversion x-ray imager** [7449-68]
K. Wang, Univ. of Waterloo (Canada) and Thunder Bay Regional Research Institute (Canada); F. Chen, Univ. of Waterloo (Canada); G. Belev, S. O. Kasap, Univ. of Saskatchewan (Canada); K. S. Karim, Univ. of Waterloo (Canada)

Author Index

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- 3 CZT Detectors II
Kevin Gutierrez, U. S. Department of Homeland Security (United States)
- 4 Scintillators I
Henry Chen, Redlen Technologies (Canada)
- 5 CdTe
Michael Fiederle, Albert-Ludwigs-Universität Freiburg (Germany)
- 6 CZT Characterization II
Kelvin G. Lynn, Washington State University (United States)
- 7 Crystal Growth
Robert D. McLaren, Consultant (United States)
- 8 Imaging Applications
Henry Chen, Redlen Technologies (Canada)

- 9 Neutron Detectors
Zane W. Bell, Oak Ridge National Laboratory (United States)
- 10 Chalcogenide Detectors
Paul J. Sellin, University of Surrey (United Kingdom)
- 11 CMT and TlBr
Keitaro Hitomi, Tohoku Institute of Technology (Japan)
- 12 Scintillators II
Larry A. Franks, U. S. Department of Energy (United States)
- 13 Other Novel Detector Materials
Giuseppe S. Camarda, Brookhaven National Laboratory
(United States)

Introduction

This book contains the proceedings of the SPIE Conference on Hard X-Ray, Gamma-Ray, and Neutron Detector Physics XI. The conference was held on August 3–6, 2009 in San Diego, California. The conference was organized into technical sessions on cadmium zinc telluride (CZT), cadmium telluride, scintillators, crystal growth, neutron detectors, chalcogenide materials, CMT and TlBr, imaging, and novel semiconductor detector materials. A plenary presentation and a poster session were also provided.

The purpose of the conference was to provide a forum for scientists and engineers from the detector development and user communities to present and evaluate the most recent results on X-ray, gamma-ray, and neutron detectors and to discuss the requirements for a variety of radiation-sensing and imaging applications. The primary theme of the conference was on development of improved semiconductor and scintillator radiation detectors and imaging arrays, which combine the advantages of room-temperature operation with the ability to spectrally resolve the energies of emitted X- and gamma-rays. By eliminating the cryogen, new radiation-sensing instruments, such as spectrometers, gamma cameras, and radiographic systems, can be manufactured that are portable, lightweight, easy to operate, and relatively maintenance-free. Recent research and development on detectors have resulted in measurable progress in the availability of single detectors and imaging arrays. In addition, recent reports of the material properties limiting the performance of semiconductor and scintillator detectors have provided new insights and directions to address deficiencies in the crystals and devices.

Despite the limitations on efficiency and relatively high cost of current room-temperature semiconductor detectors, they have been increasingly deployed in systems useful for medical diagnostics, space applications, safeguarding of nuclear materials, material identification, baggage scanning, position sensing, and gamma-ray spectroscopy. Although significant progress has occurred over recent years, there is still a pressing need to lower the cost of the detectors and to increase the efficiency of room-temperature semiconductor detectors without degrading their spectral performance.

A total of 61 presentations, oral and poster, were given at the conference. Although the number of attendees varied with the session and day of week, the attendance averaged approximately 70 people with a substantial fraction of those in attendance representing organizations outside of the United States. The plenary session drew over 200 attendees.

This book provides detailed documentation describing a portion of the presentations. The editors hope that it will serve as an important record of the

meeting, provide an update on the status of X-ray, gamma-ray, and neutron detector technology, and serve as a useful source of information for those working in the field.

The conference chairs would like to thank the session chairs and members of the conference program committees, who offered their time to enlist the involvement of many researchers working in the field.

Ralph B. James
Larry A. Franks
Arnold Burger